**FORM PTO-1449** 

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. 107318-00000 APPLICANT HIRANIO et al.

Sheet <u>1</u> of <u>3</u>

SERIAL NO.

**New Divisional** 

## LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

HIRANO et al.

March \_\_\_ 2001

GROUP

Not assigned

### **U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
5-	AA	4,822,751	04/1989	ISHIZU et al.			
5	AB	4,864,376	09/1989	AOKI et al.			
5	AC	4,948,231	08/1990	AOKI et al.			
5-	AD	5,323,042	06/1994	MATSUMOTO			
5-	ΑE	5,459,346	10/1995	ASAKAWA et al.			
5~	AF	5,576,556	11/1996	TAKEMURA et al.			

#### **FOREIGN PATENT DOCUMENTS**

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TR/ YES	TRANSLATION YES NO PART.	
Sim	AG	03-286518	02.04.90	Japan					×
5~	AH	60-257511	04.06.84	Japan					×
Su	Al	60-245174	18.05.84	Japan					х
5-	AJ	06-267982	09/22/94	Japan			Х		
8-	AK	06-296023	10/21/94	Japan			х		
8	AL	7-176748	07/1995	Japan					х

OTHER REFERENCES (Including Author Title Date Pertinent Pages Etc.)

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\*EXAMINER:

Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Sheet 2 of 3 ATTY. DOCKET NO. SERIAL NO. 107318-00000 New Divisional APPLICANT HIRANO et a FILING DATE **GROUP** 

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5	AA	5,563,427	10/1996	YUDASAKA et al.							
5	AB	6,048,757	Apr. 2000	TAKEMURA							
5	AC	5,618,741	Apr. 1997	YOUNG et al.							
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3-	ΑE	5,529,937	7/20/94	ZHANG et al.							
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AG	260645	Sept. 16, 1994	Japan					x
 AH 104117 Ma		May 14, 1987	Japan					x
 Al	29924	Feb. 8, 1998	Japan					X
AJ	145775	June 29, 1987	Japan					x
 AK	335890	Dec. 22, 1995	Japan					x
AL								

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Sheet 3 of 3

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5-	AC	4,502,205	03/1985	YAHANO								
7	AD			/								
	AE											
	AF											
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						SUB- CLASS	TRANSLATION YES NO PART.					
	AG											
	АН											
	AI											
	AJ											
	AK											
	AL											
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